



International  
Standard

ISO 19397

First edition  
2024-11

# Paints and varnishes — Determination of the film thickness of coatings using an ultrasonic gauge

*Peintures et vernis — Détermination de l'épaisseur du feuil de  
revêtements par mesurage par ultrasons*

STANDARDSISO.COM : Click to view the full PDF  
ISO 19397:2024

STANDARDSISO.COM : Click to view the full PDF of ISO 19397:2024



**COPYRIGHT PROTECTED DOCUMENT**

© ISO 2024

All rights reserved. Unless otherwise specified, or required in the context of its implementation, no part of this publication may be reproduced or utilized otherwise in any form or by any means, electronic or mechanical, including photocopying, or posting on the internet or an intranet, without prior written permission. Permission can be requested from either ISO at the address below or ISO's member body in the country of the requester.

ISO copyright office  
CP 401 • Ch. de Blandonnet 8  
CH-1214 Vernier, Geneva  
Phone: +41 22 749 01 11  
Email: [copyright@iso.org](mailto:copyright@iso.org)  
Website: [www.iso.org](http://www.iso.org)

Published in Switzerland

## Contents

Page

<b>Foreword</b>	iv
<b>Introduction</b>	v
<b>1 Scope</b>	1
<b>2 Normative references</b>	1
<b>3 Terms and definitions</b>	1
<b>4 Principle</b>	4
<b>5 Physical principles of the measuring method and of the application</b>	5
<b>6 Apparatus and materials</b>	6
6.1 Ultrasonic film thickness measuring device	6
6.2 Couplant	7
6.3 Calibration standards	7
<b>7 Calibration, adjustment and checking of the measuring device</b>	7
7.1 Calibration	7
7.2 Adjustment	7
7.3 Checking the adjustment	7
<b>8 Procedure of measurement</b>	7
<b>9 Temperature influence during the measurement</b>	8
<b>10 Precision</b>	8
10.1 General	8
10.2 Repeatability limit	8
10.3 Reproducibility limit	9
<b>11 Test report</b>	10
<b>Annex A (informative) Quality of the personnel</b>	11
<b>Annex B (informative) Determination of precision</b>	12
<b>Bibliography</b>	18

## Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular, the different approval criteria needed for the different types of ISO document should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see [www.iso.org/directives](http://www.iso.org/directives)).

ISO draws attention to the possibility that the implementation of this document may involve the use of (a) patent(s). ISO takes no position concerning the evidence, validity or applicability of any claimed patent rights in respect thereof. As of the date of publication of this document, ISO had not received notice of (a) patent(s) which may be required to implement this document. However, implementers are cautioned that this may not represent the latest information, which may be obtained from the patent database available at [www.iso.org/patents](http://www.iso.org/patents). ISO shall not be held responsible for identifying any or all such patent rights.

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation of the voluntary nature of standards, the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT), see [www.iso.org/iso/foreword.html](http://www.iso.org/iso/foreword.html).

This document was prepared by Technical Committee ISO/TC 35, *Paints and varnishes*, Subcommittee SC 9, *General test methods for paints and varnishes*, in collaboration with the European Committee for Standardization (CEN) Technical Committee CEN/TC 139, *Paints and varnishes*, in accordance with the Agreement on technical cooperation between ISO and CEN (Vienna Agreement).

This first edition cancels and replaces ISO/TS 19397:2015, which has been technically revised.

The main changes are as follows:

- an introduction has been added;
- the normative references have been updated.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at [www.iso.org/members.html](http://www.iso.org/members.html).

## Introduction

This document consistently enumerates the individual coatings applied in a multi-layer system by referring to the first coating applied on the substrate as coating 1. Some other standards referring to individual test methods enumerate in reverse order. See ISO 2808 for example.

STANDARDSISO.COM : Click to view the full PDF of ISO 19397:2024

STANDARDSISO.COM : Click to view the full PDF of ISO 19397:2024

# Paints and varnishes — Determination of the film thickness of coatings using an ultrasonic gauge

## 1 Scope

This document specifies a method for determining the film thickness of coatings on metallic and non-metallic substrates using an ultrasonic gauge.

## 2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 4618, *Paints and varnishes — Vocabulary*

ISO Guide 99, *International vocabulary of metrology — Basic and general concepts and associated terms (VIM)*

## 3 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO 4618 and the following apply.

ISO and IEC maintain terminology databases for use in standardization at the following addresses:

- ISO Online browsing platform: available at <https://www.iso.org/obp>
- IEC Electropedia: available at <https://www.electropedia.org/>

### 3.1

#### ultrasonic wave

acoustic wave having a frequency higher than the audible range of the human ear, generally taken as higher than 20 kHz

[SOURCE: ISO 5577:2017, 3.2.1]

### 3.2

#### longitudinal wave

compressional wave

wave in which the direction of displacement of particles is in the same direction as the propagation of the wave

[SOURCE: ISO 5577:2017, 3.3.1, modified — Note 1 to entry has been removed.]

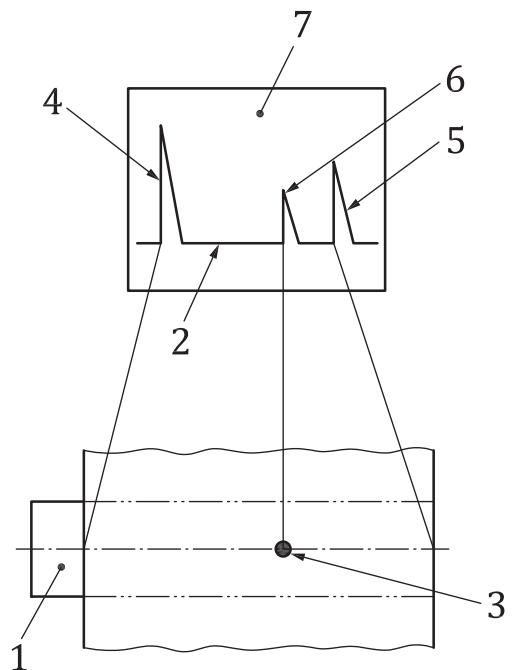
### 3.3

#### echo

signal on the display of the ultrasonic instrument received from the test object

Note 1 to entry: See [Figure 1](#) for an *A-scan presentation* ([3.13](#)) where the echo can be seen in the key, references 5 and 6.

Note 2 to entry: Depending on the test setup, additional echoes can be received.

**Key**

1	straight-beam probe	5	back-wall echo
2	time base	6	reflector echo
3	reflector	7	A-scan presentation
4	transmitter pulse indication		

**Figure 1 — A-scan presentation**

[SOURCE: ISO 5577:2017, 6.5.1 modified – Note 1 to entry has been amended.]

**3.4****echo height**

height of an *echo* (3.3) indication on the display

[SOURCE: ISO 5577:2017, 6.5.6]

**3.5****ultrasonic impulse**

short-lived ultrasound signal

**3.6****ultrasonic sensor**

ultrasonic probe

device for sending and receiving *ultrasonic waves* (3.1), mostly based on piezoelectric materials

**3.7****acoustic impedance**

*Z*

product of sound velocity and density of a material

**3.8****reflection coefficient**

ratio of reflected sound pressure to incident sound pressure at a reflecting surface

Note 1 to entry: For a wave, the reflection coefficient *R* is calculated from the *acoustic impedances* (3.7)  $Z_1$  and  $Z_2$  of the bordering media, for which 1 is the medium of the incoming sound:

$$R = \frac{Z_2 - Z_1}{Z_2 + Z_1}$$

For a negative reflection coefficient, the *phase* (3.9) of the reflected signal is changed by 180°.

[SOURCE: ISO 5577:2017, 4.4.8, modified — Note 1 to entry has been replaced.]

### 3.9

#### phase

momentary condition of a vibration expressed as an arc measurement or an angle

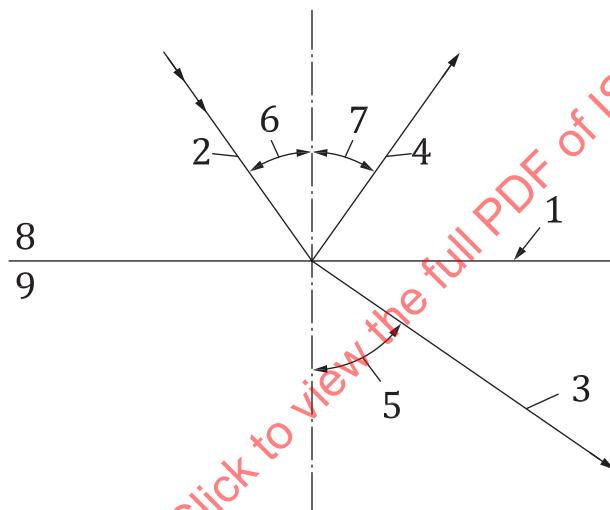
[SOURCE: ISO 5577:2017, 3.2.3]

### 3.10

#### interface

boundary between two materials, in acoustic contact, having different acoustic properties

Note 1 to entry: See [Figure 2](#).



#### Key

1	interface	6	angle of incidence
2	direction of incident wave	7	angle of reflection
3	direction of refracted wave	8	medium 1
4	direction of reflected wave	9	medium 2
5	angle of refraction		

**Figure 2 — Refraction and reflection of waves**

[SOURCE: ISO 5577:2017, 4.4.1]

### 3.11

#### sound path travel time

time it takes for ultrasonic pulses to travel along the sound path travel distance

[SOURCE: ISO 5577:2017, 6.7.5]

**3.12****couplant**

coupling medium

medium interposed between the probe and the test object to enable the passage of ultrasound between them, such as water, glycerine or oil

[SOURCE: ISO 5577:2017, 6.3.3, modified — Note 1 to entry has been removed.]

**3.13****A-scan presentation**

display of the ultrasonic signals in which the X-axis represents the time and the Y-axis represents the amplitude

Note 1 to entry: See [Figure 1](#).

[SOURCE: ISO 5577:2017, 6.6.1]

**3.14****calibration**

operation that, under specified conditions, in a first step, establishes a relation between the quantity values with measurement uncertainties provided by measurement standards and corresponding indications with associated measurement uncertainties and, in a second step, uses this information to establish a relation for obtaining a measurement result from an indication

Note 1 to entry: A calibration may be expressed by a statement, calibration function, calibration diagram, calibration curve or calibration table. In some cases, it may consist of an additive or multiplicative correction of the indication with associated measurement uncertainty.

Note 2 to entry: Calibration should not be confused with *adjustment of a measuring system* ([3.15](#)), often mistakenly called “self-calibration”, nor with verification of calibration.

Note 3 to entry: Often, the first step alone in the above definition is perceived as being calibration.

[SOURCE: ISO/IEC Guide 99:2007, 2.39]

**3.15****adjustment****adjustment of a measuring system**

set of operations carried out on a measuring system so that it provides prescribed indications corresponding to given values of a quantity to be measured

Note 1 to entry: Types of adjustment of a measuring system include zero adjustment of a measuring system, offset adjustment and span adjustment (sometimes called “gain adjustment”).

Note 2 to entry: Adjustment of a measuring system should not be confused with *calibration* ([3.14](#)), which is a prerequisite for adjustment.

Note 3 to entry: After adjustment of a measuring system, the measuring system should only be recalibrated if the tolerance values specified for the gauge are no longer met.

[SOURCE: ISO/IEC Guide 99:2007, 3.11 modified — Note 3 to entry has been changed]

**3.16****working standard**

standard which is traceable to the national standard

[SOURCE: EN 60731:2012, 3.4.1.2]

## 4 Principle

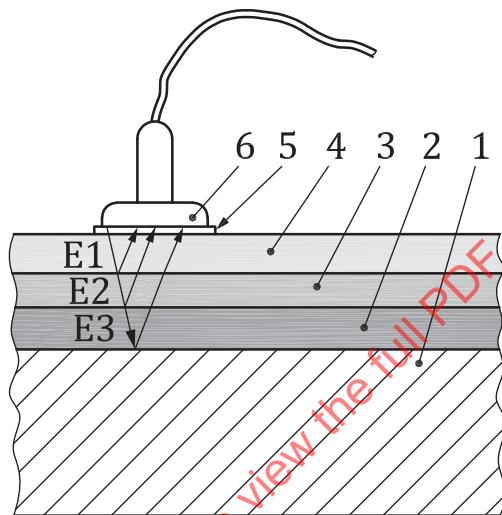
The method described in this document determines single film thicknesses from the times of flight of an ultrasonic impulse that is partially reflected at the interfaces of the coating system. The strengths and

weaknesses of the method are shown by measuring data for the different film-substrate combinations that are relevant in practice.

## 5 Physical principles of the measuring method and of the application

When measuring the film thickness using ultrasound, longitudinal waves are used because they can be easily generated and coupled into a work piece with almost every liquid. As shown in [Figure 3](#), a sensor (key, reference 6) consists of a piezoelectric disc or film, for sound generation and for reception, and of a “delay path”. The ultrasonic impulse generated in the sensor first passes the delay path and then spreads through layers 1 to 3 down to the substrate (key, reference 1) and beyond.

On each interface, a fraction of the impinging ultrasonic wave is reflected as a new ultrasonic impulse, while another fraction passes through. The first reflection occurs in the ultrasonic sensor when the ultrasonic impulse impinges on the couplant (key, reference 5).



### Key

- 1 substrate
- 2 layer 3
- 3 layer 2
- 4 layer 1
- 5 couplant (liquid)
- 6 ultrasonic sensor (sender and receiver)
- E echo 1, 2, 3

**Figure 3 — Ultrasonic method**

Ultrasonic impulses are recorded when they are received in the ultrasonic sensor. The distances of time between the ultrasonic impulses correspond to the sound path travel times  $T_i$  ( $i = 1, 2, 3$ ) in the three individual layers. The amplitude or echo height of the ultrasonic impulse reflected on each interface depends on the respective reflection factors. If the sound velocity in each single layer is known, the respective film thickness can be calculated by means of the times of flight. For each layer, [Formula \(1\)](#) applies:

$$v = \frac{t_d}{T / 2} \quad (1)$$

where

- $v$  is the sound velocity;
- $t_d$  is the dry film thickness;
- $T$  is the sound path travel time in the layer (back and forth).

In order to be able to resolve echoes with short intervals of sound path travel times with the naked eye (e.g. 20 ns in a 20  $\mu\text{m}$  thick coating), the ultrasonic impulses shall be at least just as short. For this, the ultrasonic frequencies shall be respectively high (at least the reciprocal of half of the time of flight). If the ultrasonic sensor does not supply this frequency characteristics, the A-scan is generated from high frequency components using digital signal processing. For an example of an A-scan, see [Figure 4](#).

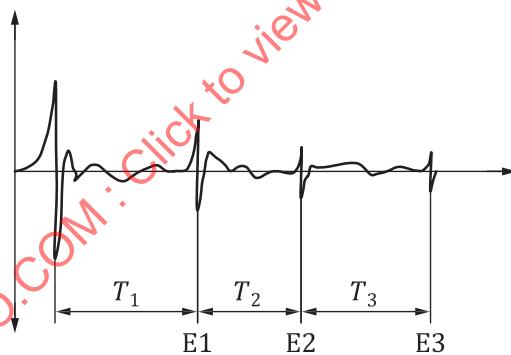
When layers are too thin, the echoes of the individual layers merge into each other. In this case, an optic control of the evaluation in the A-scan presentation is no longer possible.

In cases where the A-scan presentation shows positive and negative half-waves, it shall be taken into account that for a negative reflection factor ( $Z_2 < Z_1$ ), the phase of the ultrasonic impulse changes by 180°. If this is ignored, a relative time delay of a half wavelength can occur.

The precondition for ultrasonic impulses with signal amplitudes sufficiently high for evaluation forming at the interface of two layers is:

- a sufficiently high reflection coefficient or respectively different acoustic impedances  $Z$ , and
- a clearly defined intersection between the materials.

Otherwise, the reflections can become too low for detection. This can also occur with curved work pieces where, due to geometry, not all sound fractions simultaneously re-impinge from the interface on the sensor.



#### Key

$T_1, T_2, T_3$  sound path travel times for layers 1, 2, 3

$E1, E2, E3$  echo for layers 1, 2, 3

**Figure 4 — Example of an A-scan presentation**

## 6 Apparatus and materials

### 6.1 Ultrasonic film thickness measuring device

Use a device with an ultrasonic sensor for sending and receiving ultrasonic impulses and an evaluation unit for determining the film thickness over the time of flight (see [Figure 3](#)).

**NOTE** The ultrasonic sensors used for measuring the film thickness generate ultrasonic signals (longitudinal waves), which spread perpendicularly to the surface of the work piece and the coating. In the schematic diagram in [Figure 3](#), a slant representation of the sound propagation was selected only for illustrating the sound generation.

## 6.2 Couplant

An acoustic contact between probe and test specimen with sufficient coupling shall be enabled. Commonly, a liquid (e.g. water or oil) or a gel couplant is applied.

## 6.3 Calibration standards

For checking the function of a measuring device, a working standard, as defined in ISO Guide 99, shall be used.

For checking the measuring method and for adjusting the device prior to use, a working measurement standard, as defined in ISO Guide 99, shall be used, which largely corresponds to the respective test object to be measured regarding film thickness, coating system, substrate and thicknesses of the layers.

# 7 Calibration, adjustment and checking of the measuring device

## 7.1 Calibration

For information on the quality of the personnel, see [Annex A](#).

Calibrate the device in accordance with the manufacturer's information.

**NOTE** Primarily, the time of flight of a signal is measured with the measuring devices. This time of flight can be checked, if necessary, with a calibration standard with defined thickness and known sound velocity.

## 7.2 Adjustment

Adjust the device in accordance with the manufacturer's information.

When adjusting the entering of sound velocities, it is recommended to use test specimens that are based on the minimum and maximum film thicknesses that would be expected for the determination of these sound velocities. Using the ultrasonic film thickness measuring device, the time of flight of the ultrasonic impulse and the sound velocities, in accordance with [Formula \(1\)](#), are determined in the same measuring area in which the film thickness was or will be determined with an alternative method.

The determination of the time of flight is carried out repeatedly on each test specimen and the mean is taken for each test specimen.

When selecting the test specimens to use for the determination of the sound velocity, it should be considered that the thinner the test specimens and the lower the sound path travel times, the more imprecise the determination of the sound velocity from time of flight and thickness.

When calculating, it shall be observed that the data are entered in the units used by the manufacturer of the device. Thereafter, the data shall be converted into SI units.

## 7.3 Checking the adjustment

Prior to recording the measurements, after turning the device on, and for alterations of the coating system or substrate of the test object, the adjustment of the measuring device shall be checked by means of a working standard.

All the device settings should always be according to the manufacturer's information.

After any necessary adjustment, device settings that influence the ultrasonic signals shall not be changed. When exchanging the probe or changing the device settings, a calibration should be performed.

# 8 Procedure of measurement

Operate the device in accordance with the manufacturer's information.

Apply some couplant to the coating and measure its film thickness. Lay the probe perpendicularly onto the coating and press so that the film of couplant becomes as thin as possible and triggers measurement. Working with devices that use continuous measurement, keep the probe calmly in the measuring position until a stable measuring value is displayed.

## 9 Temperature influence during the measurement

Most of the probes are intended to be used between  $-20\text{ }^{\circ}\text{C}$  and  $+60\text{ }^{\circ}\text{C}$ . However, it is recommended to carry out ultrasonic film thickness measurements, preferably in the range of common ambient temperatures, to keep the test object, couplant and probe at an equilibrium temperature during measuring. Temperature gradients in the delay path of the probe or in the test object influence the measuring results due to uncontrollable changes and fluctuations of the sound velocity.

In all materials, the sound velocity depends more or less on the temperature.

NOTE For polymers, the changes are typically in the range of 0,1 % to 0,3 % per  $^{\circ}\text{C}$  for a negative temperature coefficient.

To minimize errors due to temperature changes, constant temperature conditions should be observed. Adjusting and subsequent measuring shall be carried out at the same temperature. In cases where there are prolonged breaks between the measurements and changes of the ambient temperature the adjustment shall be checked.

## 10 Precision

### 10.1 General

For further information on the determination of precision, see [Annex B](#).

### 10.2 Repeatability limit

The repeatability limit  $r$  is the value below which the absolute difference between two test results (each the mean of three valid determinations) can be expected to lie when this method is used under repeatability conditions. In this case, the test results are obtained on identical material by one operator in one laboratory within a short interval of time using the described test method. The repeatability limit  $r$  in accordance with this document, calculated with a probability of 95 %, corresponds to the values given in [Tables 1](#) and [2](#).

**Table 1 – Repeatability limit ( $r$ ) for individual test specimens**

Test specimen	Film thickness $\mu\text{m}$	Repeatability limit ( $r$ ) $\mu\text{m}$
Spruce veneered	100	4
Spruce sanded	100	6
Beech veneered	100	6
Beech sanded	100	6
Aluminium	22	3
Aluminium	44	4
Carbon-fibre composite	22	3
Carbon-fibre composite	44	3
PP (polypropylene)	22	4
PP (polypropylene)	44	4
SMC (sheet moulding compound)	22	5

**Table 1 (continued)**

Test specimen	Film thickness μm	Repeatability limit ( <i>r</i> ) μm
SMC (sheet moulding compound)	44	9
Steel	22	3
Steel	44	4

**Table 2 — Repeatability limit (*r*) for product groups**

Test specimen	Film thickness μm	Repeatability limit ( <i>r</i> ) μm
Wood test specimens	100	5
Metal (aluminium and steel)	22	3
Metal (aluminium and steel)	44	4

### 10.3 Reproducibility limit

The reproducibility limit *R* is the value below which the absolute difference between two single test results (each the mean of two valid determinations) can be expected to lie when this method is used under reproducibility conditions. In this case, the test results are obtained on identical material by operators on succeeding days during shift operation using the described test method. The reproducibility limit *R* in accordance with this document, calculated with a probability of 95 %, corresponds to the values given in [Tables 3](#) and [4](#).

**Table 3 — Reproducibility limit (*R*) for individual test specimens**

Test specimen	Film thickness μm	Reproducibility limit ( <i>R</i> ) μm
Spruce veneered	100	13
Spruce sanded	100	20
Beech veneered	100	13
Beech sanded	100	11
Aluminium	22	5
Aluminium	44	7
Carbon-fibre composite	22	4
Carbon-fibre composite	44	8
PP (polypropylene)	22	5
PP (polypropylene)	44	12
SMC (sheet moulding compound)	22	10
SMC (sheet moulding compound)	44	14
Steel	22	6
Steel	44	13

**Table 4 — Reproducibility limit ( $R$ ) for product groups**

Test specimen	Film thickness μm	Reproducibility limit ( $R$ ) μm
Wood test specimens	100	17
Metal (aluminium and steel)	22	6
Metal (aluminium and steel)	44	11

## 11 Test report

The test report shall include at least the following information:

- a) all details necessary to identify the tested product;
- b) a reference to this document, i.e. ISO 19397:2024;
- c) the result of the measurement;
- d) any deviation from the specified test method;
- e) any unusual observation (deviation) during testing;
- f) the date of the test.

**Annex A**  
(informative)

**Quality of the personnel**

An operator carrying out ultrasonic thickness measurements in accordance with this document should be introduced to the physical principles and the metrological processes of this method by highly qualified personnel. Prior to testing, they should have had metrological experience guided by that personnel.

For coating systems that have not been metrologically tested, information on the product and the materials to be tested shall be available for the operator. For the reliable setting of the devices, knowledge of the physical principles of ultrasound and a detailed understanding of the metrological processes are required. Due to metrological similarity, knowledge of the most commonly used method of ultrasonic thickness measurement is helpful. See Reference [5].

STANDARDSISO.COM : Click to view the full PDF of ISO 19397:2024

## Annex B

### (informative)

## Determination of precision

### B.1 General information on the interlaboratory test

An interlaboratory test was carried out to determine the precision of film thickness measurements using ultrasonic film thickness measuring devices. Five companies participated in the interlaboratory test.

### B.2 Test specimens

For the interlaboratory test, an aqueous standard dispersion was applied to ten different substrates (see [Table B.1](#)). The dispersion was applied repeatedly to some of the substrates to achieve higher film thicknesses.

Five test specimens of each type of substrate were prepared for each value of film thickness.

The film thickness of the wood test specimens was 100 µm.

For the other types of substrate, test specimens with film thicknesses of 22 µm and 44 µm were prepared.

For the basic calibration, separate calibration panels with identical parameters and cross sections for split-beam microscopy were prepared.

Further cross-sectional samples for the split-beam microscopy were prepared for the direct comparison of the film thickness measurement microscopy/ultrasound.

**Table B.1 — Substrates used in the interlaboratory test with the respective film thicknesses**

Substrate	Nominal film thickness µm
Spruce veneered	100
Spruce sanded	100
Beech veneered	100
Beech sanded	100
Aluminium	22
Aluminium	44
Root wood	44
Carbon-fibre composite	22
Carbon-fibre composite	44
PP (polypropylene)	22
PP (polypropylene)	44
SMC (sheet moulding compound)	22
SMC (sheet moulding compound)	44
Steel	22
Steel	44

## B.3 Ultrasonic film thickness measuring devices

The interlaboratory test was carried out using five different ultrasonic film thickness measuring devices operating with a scan frequency of  $> 200$  MHz. Devices with frequencies below 200 MHz are not suitable for all substrates.

Prior to measuring, all the devices were calibrated in accordance with the manufacturers' information.

## B.4 Repeat determination

On each test specimen, the determination was carried out in triplicate.

The three measuring points were marked on each test specimen.

## B.5 Evaluation

### B.5.1 General

The evaluation of the measuring results was carried out according to ISO 5725-2.

The test specimen root wood was determined as an outlier and therefore was ignored in the precision calculation for ultrasound.

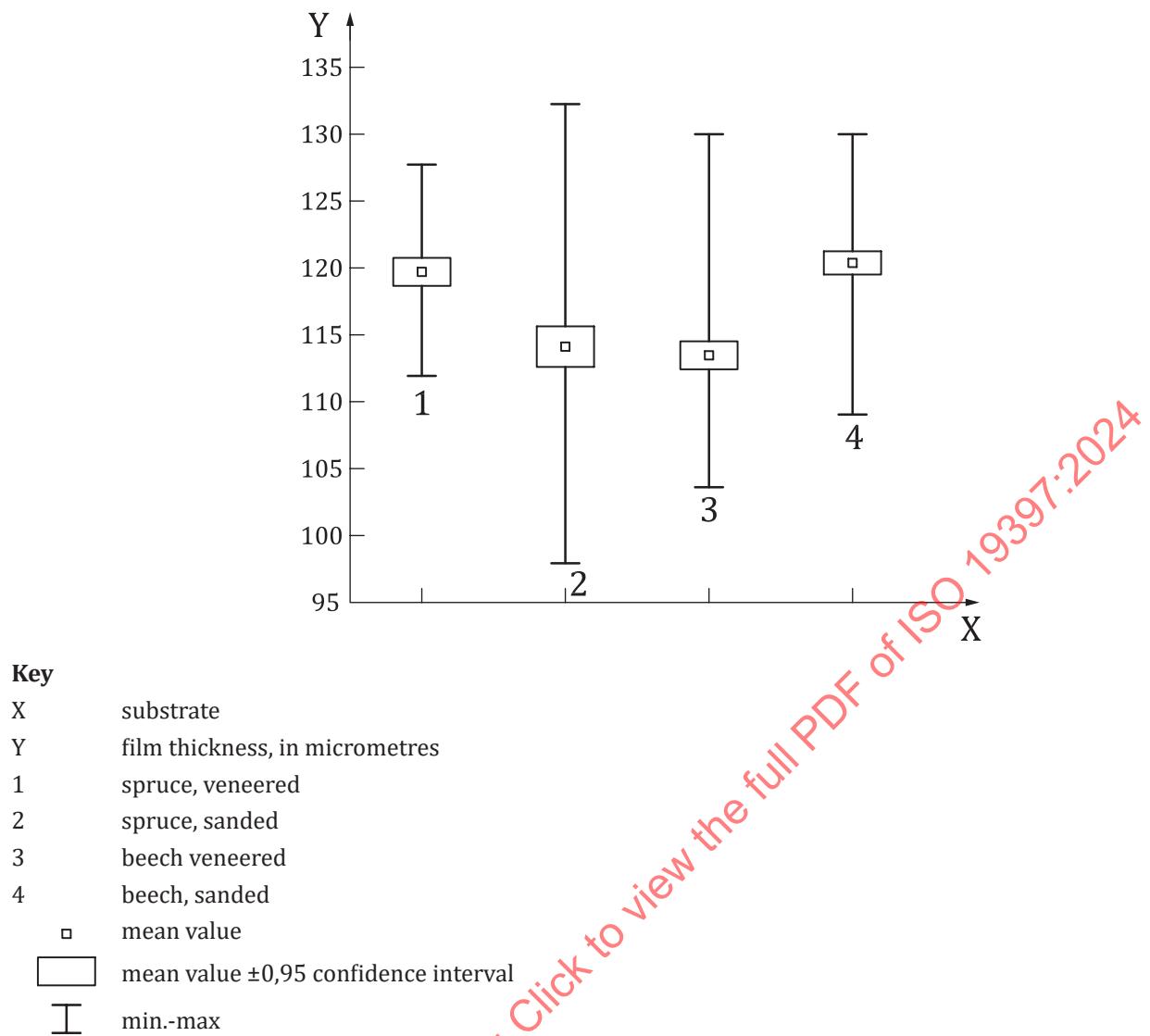
The repeatability limit and the reproducibility limit were calculated separately for each type of substrate and for each film thickness (see [Table 1](#) and [Table 3](#)).

Since the repeatability limits and reproducibility limits are similar for the wood types and also for aluminium and steel, groups of test specimens were formed for simplification and their respective repeatability limits and reproducibility limits were calculated.

### B.5.2 Repeatability limit

[Figures B.1](#), [B.2](#) and [B.3](#) show the diagrams of the respective groups of test specimens:

- wood test specimens with a film thickness of 100  $\mu\text{m}$  (see [Figure B.1](#));
- aluminium, carbon-fibre composite, PP, SMC and steel test specimens with a film thickness of 22  $\mu\text{m}$  (see [Figure B.2](#)) and 44  $\mu\text{m}$  (see [Figure B.3](#)).



**Figure B.1 — Diagram of the repeatability limit of the wood test specimens with a film thickness of 100  $\mu\text{m}$**